Ordering number : ENA0554A

SANYO Semiconductors

DATA SHEET

N-Channel Silicon MOSFET

2SK4086LS — General-Purpose Switching Device Applications

Features

- Low ON-resistance, low input capacitance, ultrahigh-speed switching.
- High reliability (Adoption of HVP process).
- Attachment workability is good by Mica-less package.
- Avalanche resistance guarantee.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V_{DSS}		600	V
Gate-to-Source Voltage	V_{GSS}		±30	V
Drain Current (DC)	I_{Dc}*1	Limited only by maximum temperature	11.5	A
	I_{Dpack}*2	SANYO's ideal heat dissipation condition	7.9	A
Drain Current (Pulse)	I_{DP}	PW≤10μs, duty cycle≤1%	43	A
Allowable Power Dissipation	P_D		2.0	W
		Tc=25°C (SANYO's ideal heat dissipation condition)	37	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C
Avalanche Energy (Single Pulse) *3	E_{AS}		79	mJ
Avalanche Current *4	I_{AV}		11.5	A

*1 Shows chip capability

*2 Package limited

*3 V_{DD}=99V, L=1mH, I_{AV}=11.5A

*4 L≤1mH, single pulse

Marking : K4086

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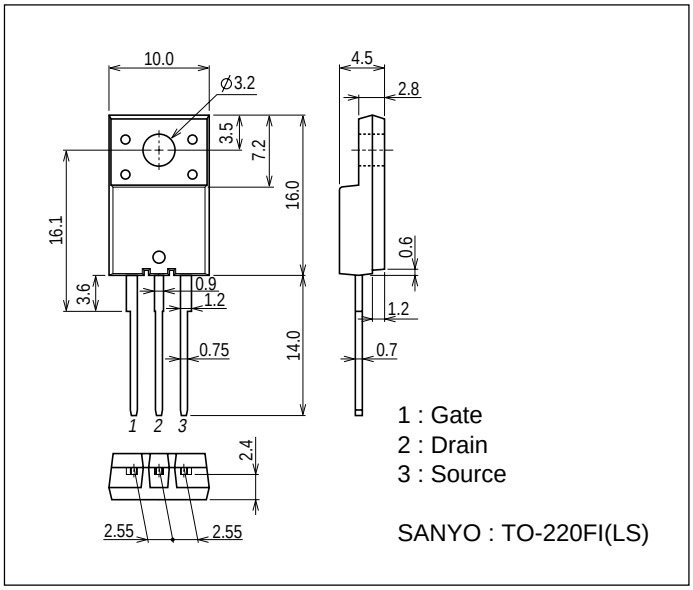
Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	I_D=10mA, V_{GS}=0V	600			V
Zero-Gate Voltage Drain Current	I_{DSS}	V_{DS}=480V, V_{GS}=0V			100	μA
Gate-to-Source Leakage Current	I_{GSS}	V_{GS}=±30V, V_{DS}=0V			±100	nA
Cutoff Voltage	V_{GS}(off)	V_{DS}=10V, I_D=1mA	3		5	V
Forward Transfer Admittance	|yfs|	V_{DS}=10V, I_D=6A	3.5	7		S
Static Drain-to-Source On-State Resistance	R_{DS}(on)	I_D=6A, V_{GS}=10V		0.58	0.75	Ω
Input Capacitance	Ciss	V_{DS}=30V, f=1MHz		1000		pF
Output Capacitance	Coss	V_{DS}=30V, f=1MHz		180		pF
Reverse Transfer Capacitance	Crss	V_{DS}=30V, f=1MHz		40		pF
Turn-ON Delay Time	t_d(on)	See specified Test Circuit.		22		ns
Rise Time	t_r	See specified Test Circuit.		43		ns
Turn-OFF Delay Time	t_d(off)	See specified Test Circuit.		120		ns
Fall Time	t_f	See specified Test Circuit.		56		ns
Total Gate Charge	Qg	V_{DS}=200V, V_{GS}=10V, I_D=11.5A		38.2		nC
Gate-to-Source Charge	Qgs	V_{DS}=200V, V_{GS}=10V, I_D=11.5A		6.7		nC
Gate-to-Drain “Miller” Charge	Qgd	V_{DS}=200V, V_{GS}=10V, I_D=11.5A		20		nC
Diode Forward Voltage	V_{SD}	I_S=11.5A, V_{GS}=0V		0.9	1.2	V

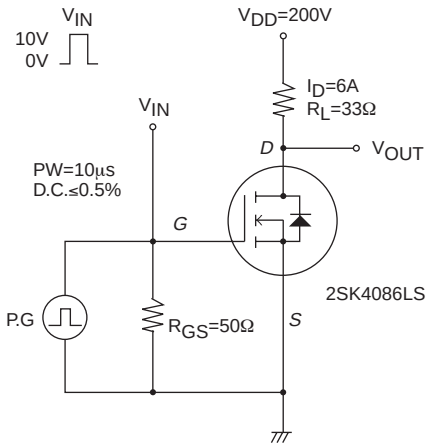
Package Dimensions

unit : mm (typ)

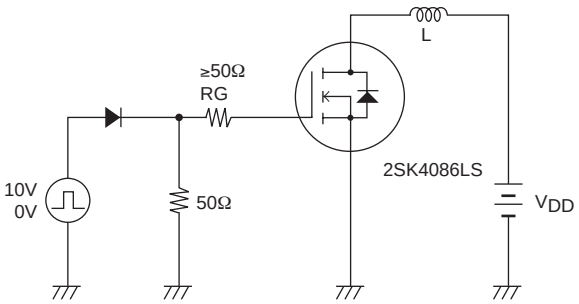
7509-002

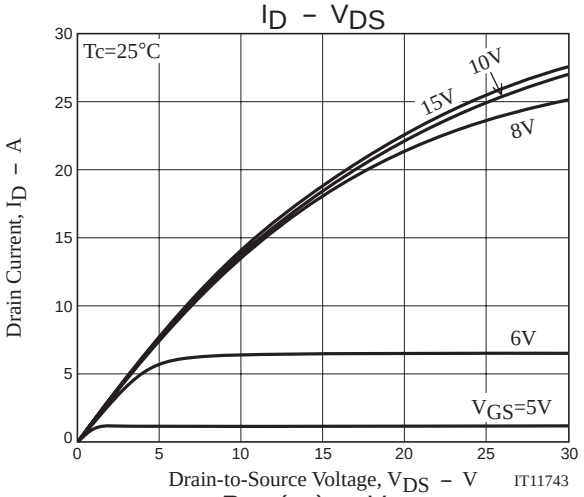


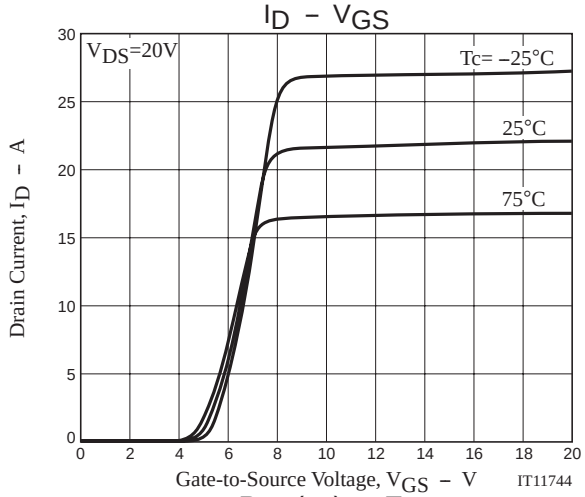
Switching Time Test Circuit

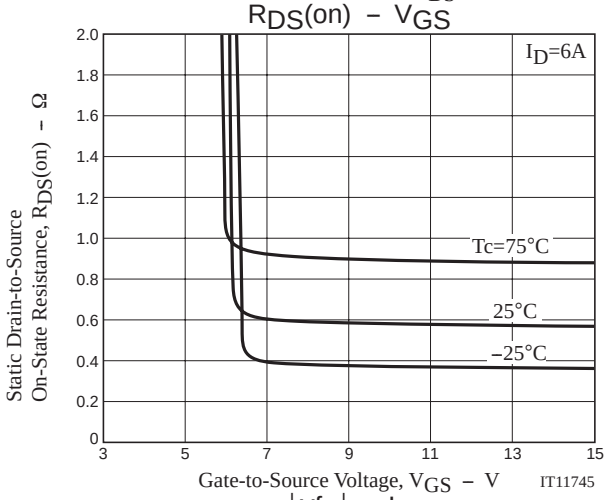


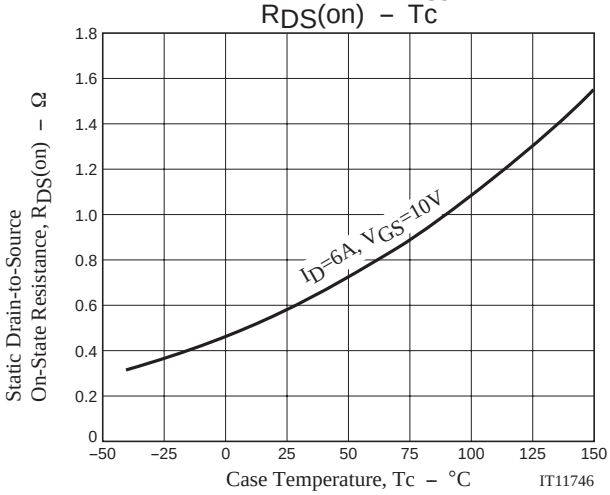
Avalanche Resistance Test Circuit

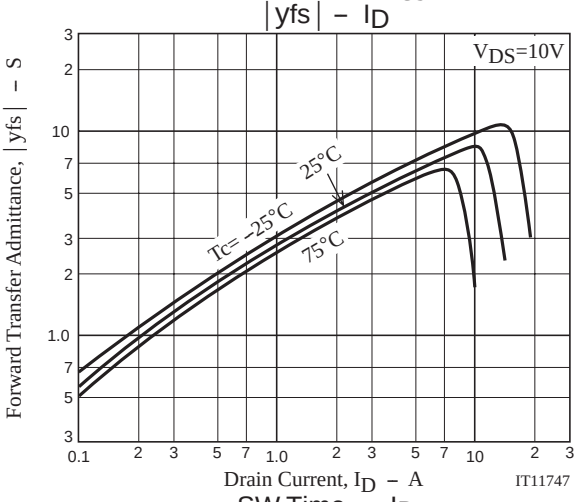


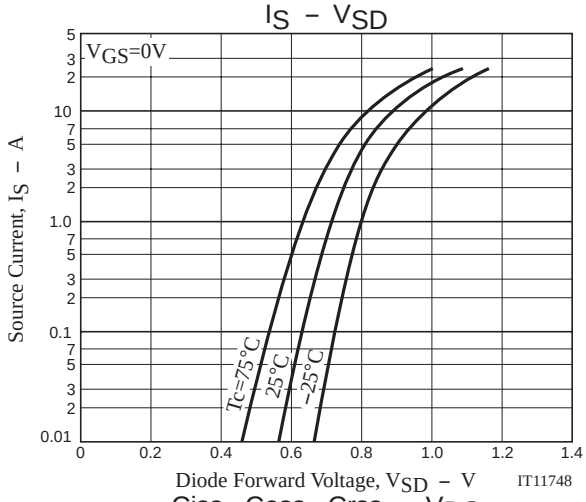

ID – VDS
Tc=25°C
10V
15V
8V
6V
VGS=5V
Drain Current, ID – A
Drain-to-Source Voltage, VDS – V
IT11743

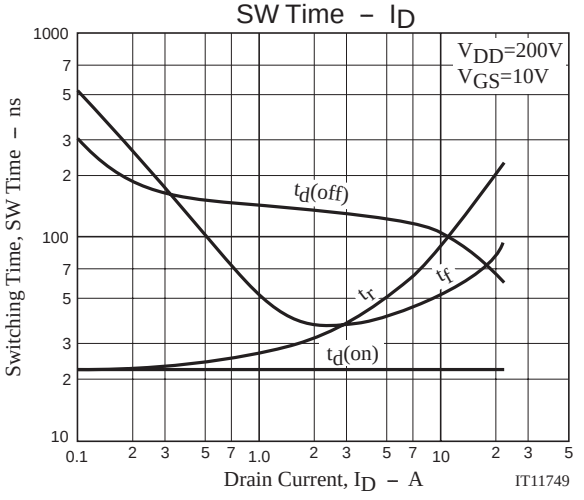

ID – VGS
VDS=20V
Tc= –25°C
25°C
75°C
Drain Current, ID – A
Gate-to-Source Voltage, VGS – V
IT11744

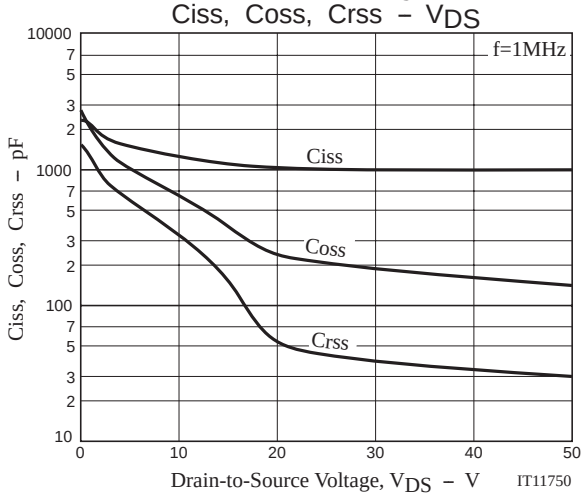

RDS(on) – VGS
ID=6A
Tc=75°C
25°C
–25°C
Static Drain-to-Source On-State Resistance, RDS(on) – Ω
Gate-to-Source Voltage, VGS – V
IT11745

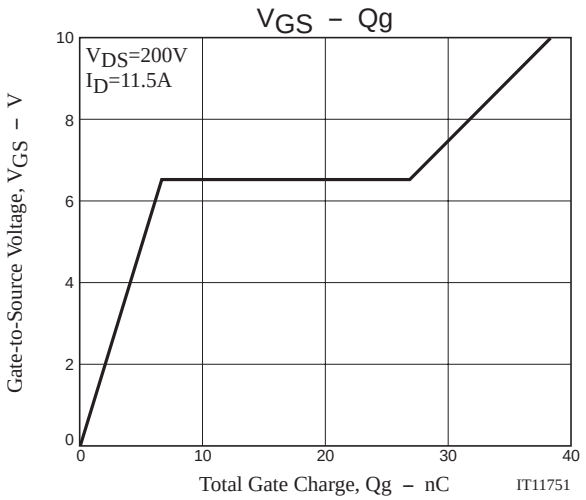

RDS(on) – Tc
ID=6A, VGS=10V
Static Drain-to-Source On-State Resistance, RDS(on) – Ω
Case Temperature, Tc – °C
IT11746

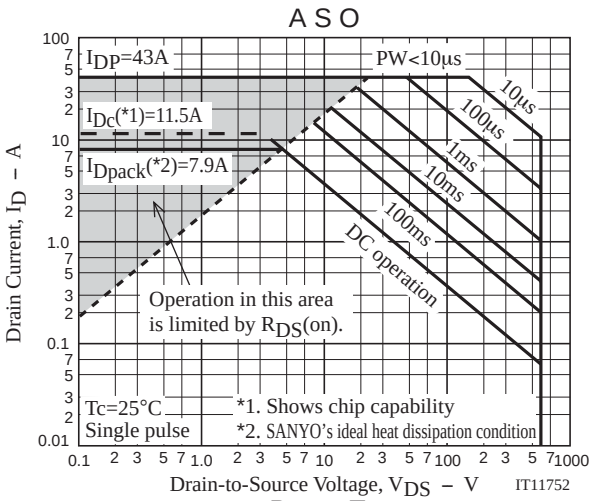

|yfs| – ID
VDS=10V
25°C
Tc= –25°C
75°C
Forward Transfer Admittance, |yfs| – S
Drain Current, ID – A
IT11747

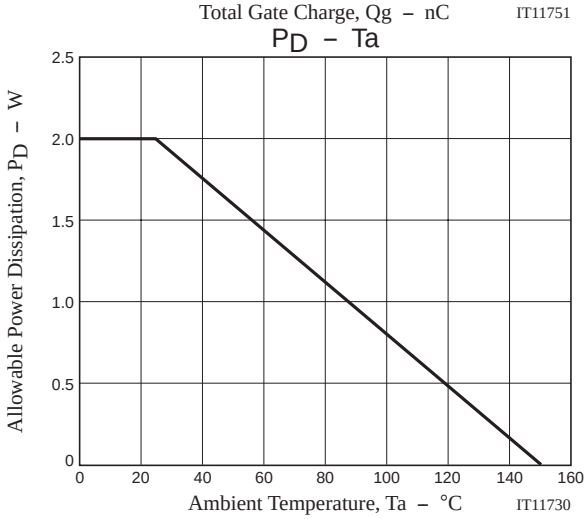

IS – VSD
VGS=0V
Tc=75°C
25°C
–25°C
Source Current, IS – A
Diode Forward Voltage, VSD – V
IT11748

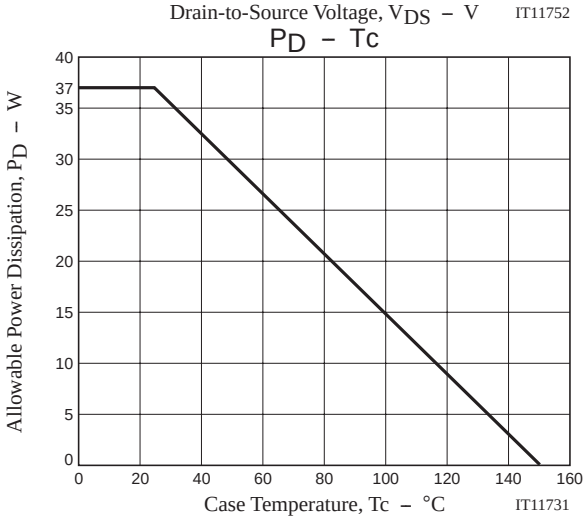

SW Time – ID
VDD=200V
VGS=10V
td(off)
tf
tr
td(on)
Switching Time, SW Time – ns
Drain Current, ID – A
IT11749

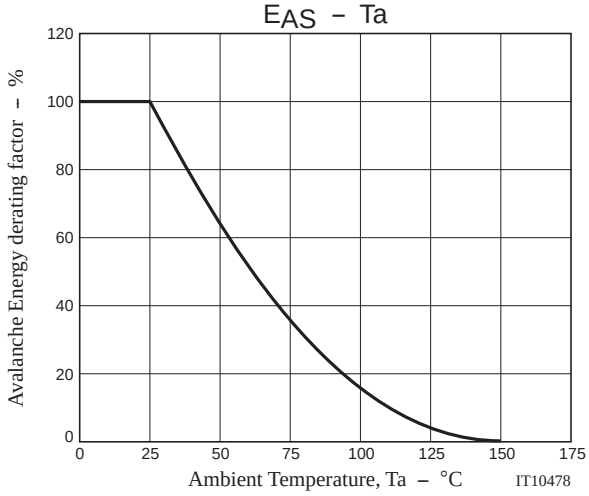

Ciss, Coss, Crss – VDS
f=1MHz
Ciss
Coss
Crss
Ciss, Coss, Crss – pF
Drain-to-Source Voltage, VDS – V
IT11750


VGS – Qg
VDS=200V
ID=11.5A
Gate-to-Source Voltage, VGS – V
Total Gate Charge, Qg – nC
IT11751


A S O
IDP=43A
PW<10μs
IDC(*1)=11.5A
IDpack(*2)=7.9A
10μs
100μs
1ms
10ms
100ms
DC operation
Operation in this area
is limited by RDS(on).
Tc=25°C
Single pulse
*1. Shows chip capability
*2. SANYO's ideal heat dissipation condition
Drain Current, ID – A
Drain-to-Source Voltage, VDS – V
IT11752


PD – Ta
Allowable Power Dissipation, PD – W
Ambient Temperature, Ta – °C
IT11730


PD – Tc
Allowable Power Dissipation, PD – W
Case Temperature, Tc – °C
IT11731


EAS – Ta
Avalanche Energy derating factor – %
Ambient Temperature, Ta – °C
IT10478

Note on usage : Since the 2SK4086LS is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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